Notice of References Cited Application/Control No. 10/037,689 Examiner Thu Ha T. Nguyen Applicant(s)/Patent Under Reexamination NEUFELD ET AL. Art Unit Page 1 of 1 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0007255	01-2002	Fujita et al.	702/188
*	В	US-6,078,951 A	06-2000	Pashupathy et al.	709/217
*	С	US-2003/0131226 A1	07-2003	Spencer et al.	713/100
*	D	US-2003/0084133 A1	05-2003	Chan et al.	709/222
*	E.	US-2002/0178295 A1	11-2002	Buczek et al.	709/250
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Q					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.